

2N5088 (SILICON)
2N5089

CASE 29 (1)
 (TO-92)

NPN silicon annular transistors designed for low-level, low-noise amplifier applications.

MAXIMUM RATINGS

Rating	Symbol	2N5088	2N5089	Unit
Collector-Emitter Voltage	V_{CEO}	30	25	Vdc
Collector-Base Voltage	V_{CB}	35	30	Vdc
Emitter-Base Voltage	V_{EB}	4.5		Vdc
Collector Current	I_C	50		mAdc
Total Device Dissipation @ $T_A = 25^\circ\text{C}$ Derate above 25°C	P_D	310	2.81	mW mW/ $^\circ\text{C}$
Operating and Storage Junction Temperature Range	T_J, T_{stg}	-55 to +135		$^\circ\text{C}$

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Ambient	θ_{JA}	0.357	$^\circ\text{C}/\text{mW}$

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS					
Collector-Emitter Breakdown Voltage ($I_C = 1.0\text{ mAdc}$, $I_B = 0$)	BV_{CEO}	30 25	- -	- -	Vdc
Collector-Base Breakdown Voltage ($I_C = 100\ \mu\text{A}$, $I_E = 0$)	BV_{CBO}	35 30	- -	- -	Vdc
Collector Cutoff Current ($V_{CB} = 20\text{ Vdc}$, $I_E = 0$) ($V_{CB} = 15\text{ Vdc}$, $I_E = 0$)	I_{CBO}	- -	- -	50 50	nA dc
Emitter Cutoff Current ($V_{EB(off)} = 3.0\text{ Vdc}$, $I_C = 0$) ($V_{EB(off)} = 4.5\text{ Vdc}$, $I_C = 0$)	I_{EBO}	- -	- -	50 100	nA dc

ON CHARACTERISTICS

DC Current Gain ($I_C = 100\ \mu\text{A}$, $V_{CE} = 5.0\text{ Vdc}$) ($I_C = 1.0\text{ mA}$, $V_{CE} = 5.0\text{ Vdc}$) ($I_C = 10\text{ mA}$, $V_{CE} = 5.0\text{ Vdc}$)	h_{FE}	300 400 350 450 300 400	- - - - - -	900 1200 -	
Collector-Emitter Saturation Voltage ($I_C = 10\text{ mA}$, $I_B = 1.0\text{ mA}$)	$V_{CE(sat)}$	-	-	0.5	Vdc
Base-Emitter On Voltage ($I_C = 10\text{ mA}$, $V_{CE} = 5.0\text{ Vdc}$)	$V_{BE(on)}$	-	-	0.8	Vdc

DYNAMIC CHARACTERISTICS

Current-Gain - Bandwidth Product ($I_C = 500\ \mu\text{A}$, $V_{CE} = 5.0\text{ Vdc}$, $f = 20\text{ MHz}$)	f_T	50	175	-	MHz
Collector-Base Capacitance ($V_{CB} = 5.0\text{ Vdc}$, $I_E = 0$, $f = 100\text{ kHz}$, emitter guarded)	C_{cb}	-	1.8	4.0	pF
Emitter-Base Capacitance ($V_{BE} = 0.5\text{ Vdc}$, $I_C = 0$, $f = 100\text{ kHz}$, collector guarded)	C_{eb}	-	4.0	10	pF
Small-Signal Current Gain ($I_C = 1.0\text{ mA}$, $V_{CE} = 5.0\text{ Vdc}$, $f = 1.0\text{ kHz}$)	h_{fe}	350 450	- -	1400 1800	-
Noise Figure ($I_C = 100\ \mu\text{A}$, $V_{CE} = 5.0\text{ Vdc}$, $R_S = 10\text{ k ohms}$, $f = 10\text{ Hz}$ to 15.7 kHz)	NF	- -	- -	3.0 2.0	dB

NOISE FIGURE
 $V_{CE} = 5.0\text{ Vdc}$, $T_A = 25^\circ\text{C}$

FIGURE 1 — FREQUENCY EFFECTS

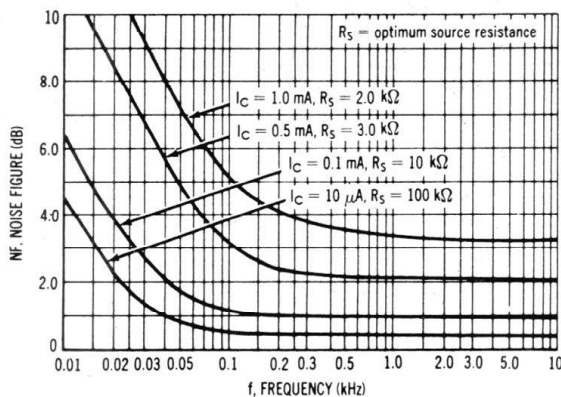
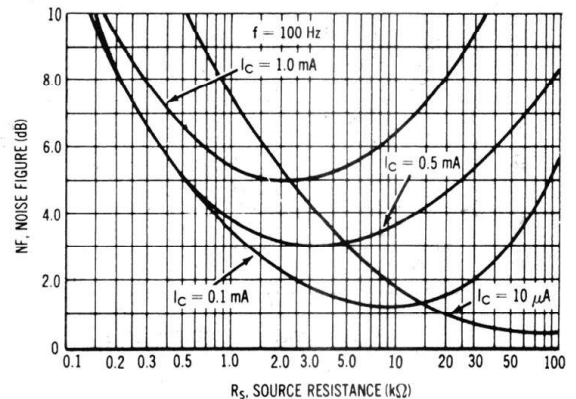


FIGURE 2 — SOURCE RESISTANCE EFFECTS



h PARAMETERS

$V_{CE} = 10 \text{ Vdc}$, $f = 1.0 \text{ kHz}$, $T_A = 25^\circ\text{C}$
(For Figures 3, 4, 5, 6, 8)

This group of graphs illustrates the relationship of the "h" parameters for this series of transistors. To obtain these curves, 4 units were selected and identified by number — the same units were used to develop curves on each graph.

FIGURE 3 — INPUT IMPEDANCE

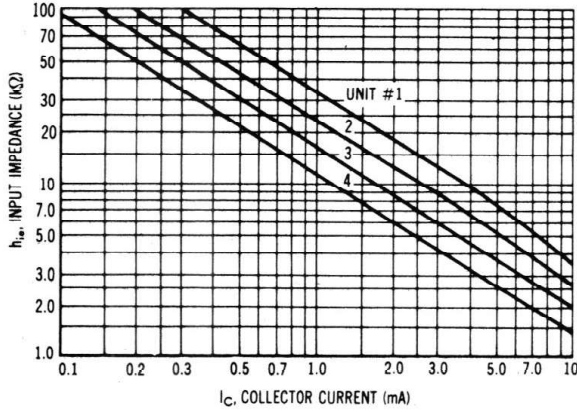


FIGURE 4 — VOLTAGE FEEDBACK RATIO

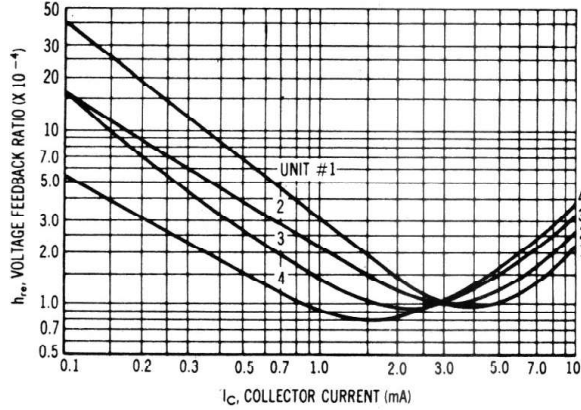


FIGURE 5 — CURRENT GAIN

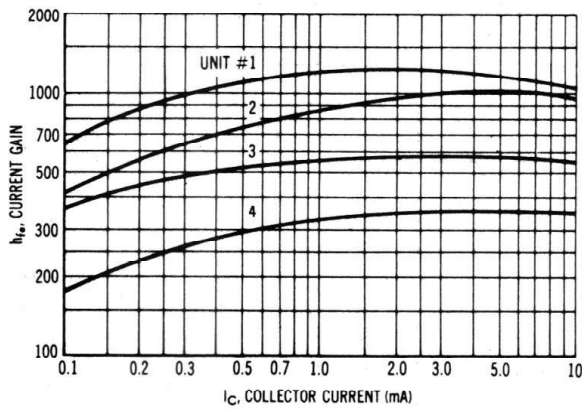


FIGURE 6 — OUTPUT ADMITTANCE

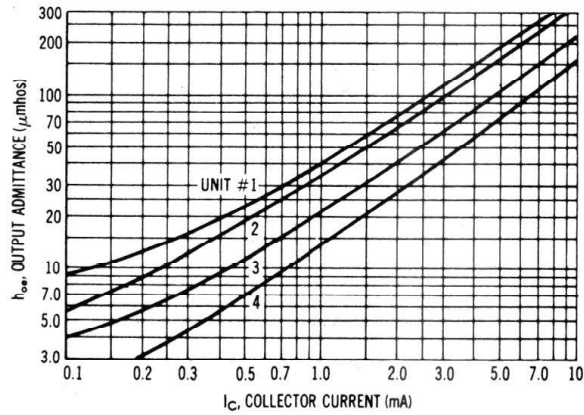


FIGURE 7 — EFFECT OF VOLTAGE

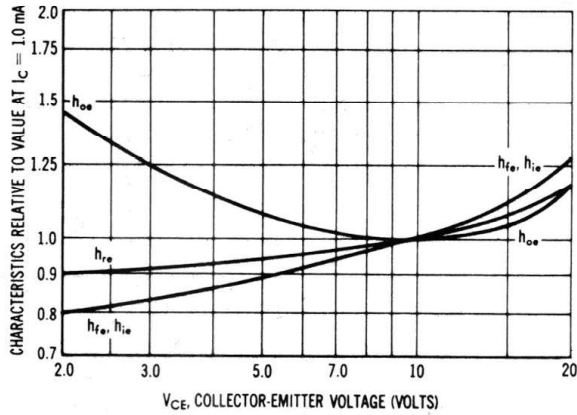


FIGURE 8 — DETERMINANT

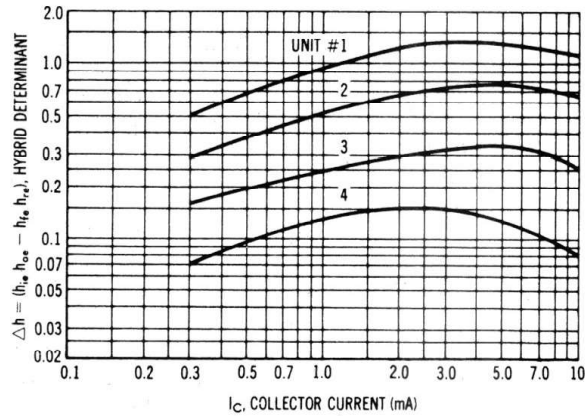


FIGURE 9 — DC CURRENT GAIN

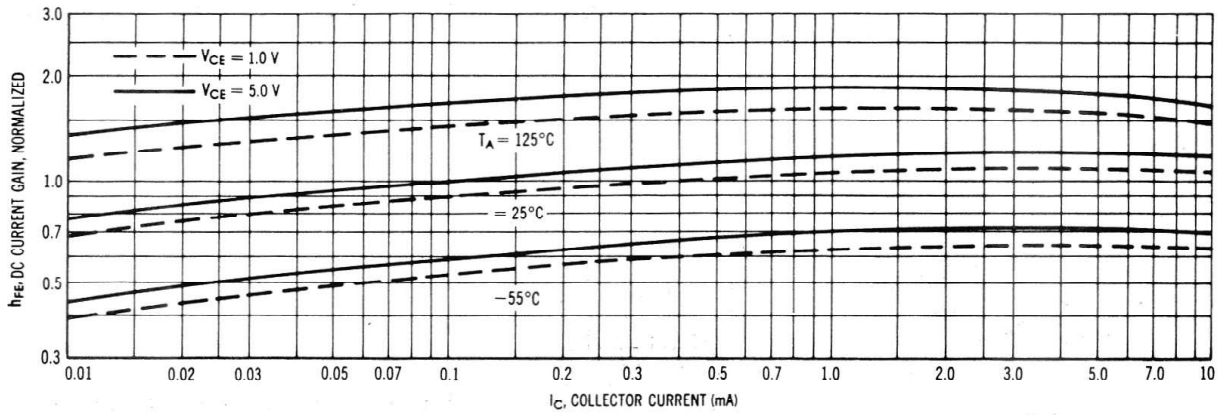


FIGURE 10 — COLLECTOR SATURATION REGION

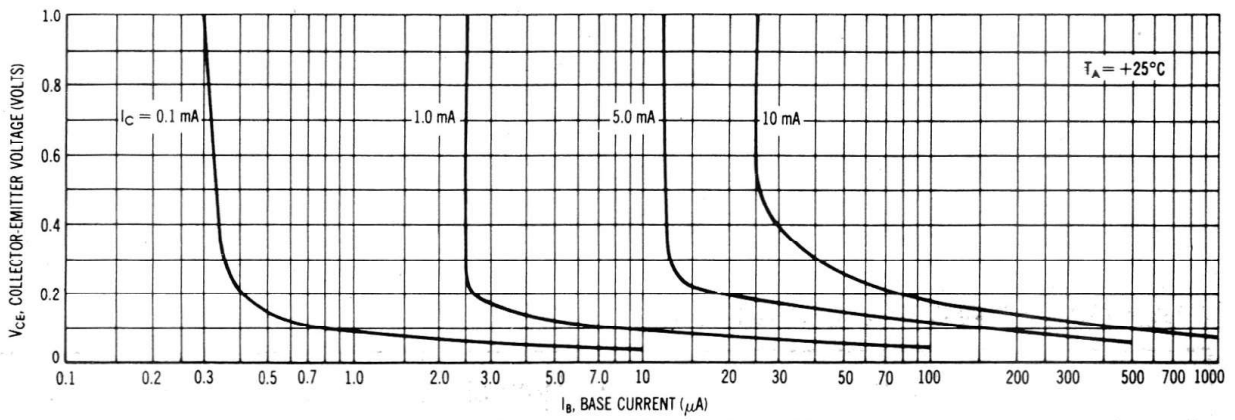


FIGURE 11 — CURRENT GAIN — BANDWIDTH PRODUCT

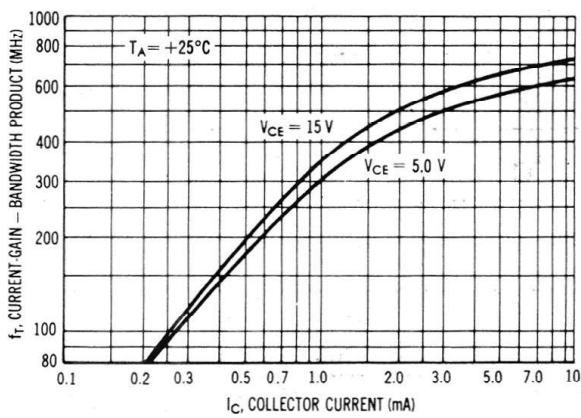


FIGURE 12 — CAPACITANCE

